## Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/558.155	WAKITA ET AL.

Examiner

JD SCHULTZ

Art Unit 1633

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			1	
	-		+	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
West including inventor search, STN in cluding Biosis, Medline, SciSearch, CAPlus, Embase. SEQ ID NO: 1	4/23/2010	JDS		